

**Search Notes**

Application/Control No.

10/007,300

Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

JONO ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	374	1/7/2005	TT
257	396-400	1/7/2005	TT
257	510, 519	1/7/2005	TT
257	647, 648	1/7/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
257	374	1/7/2005	TT
257	396-400	1/7/2005	TT
257	510,519	1/7/2005	TT
257/647-648		1/7/2005	TT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR